



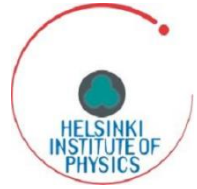
Acoustic Microscopy Imaging of Cu Samples

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Kenneth Österberg^{1,2} and Edward Hægström¹

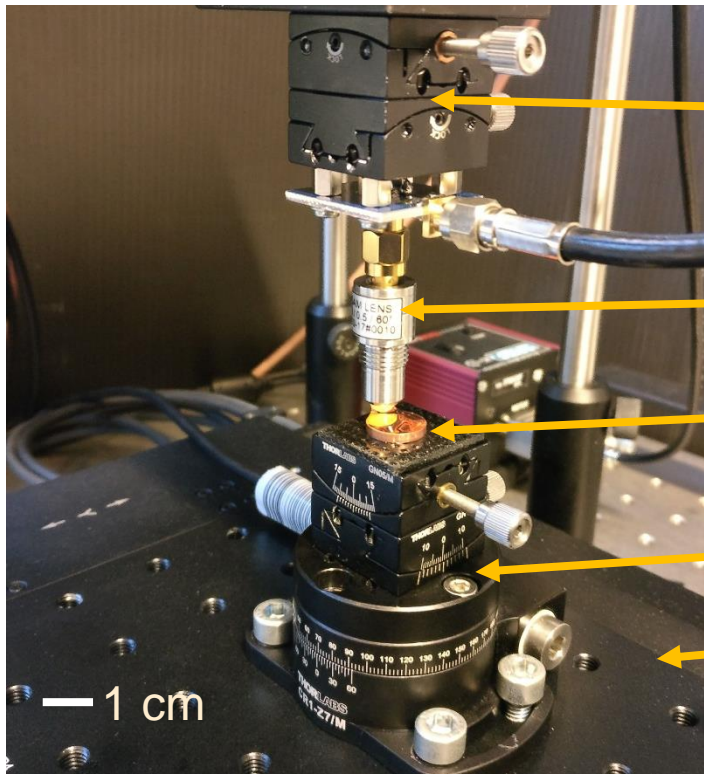
- 1) Department of Physics, University of Helsinki
- 2) Helsinki Institute of Physics



Why Acoustic Microscope



- Optical methods do not measure elasticity
- Tapping mode AFM is not easy to calibrate for elasticity
- μ CT Does not see elasticity close to the surface



Goniometer tilt stage

Ultrasound transducer

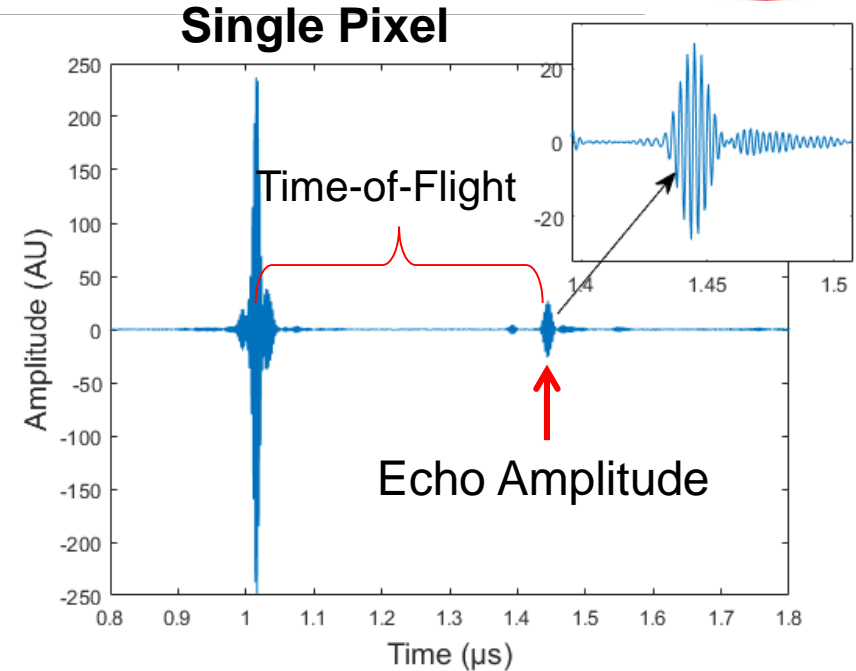
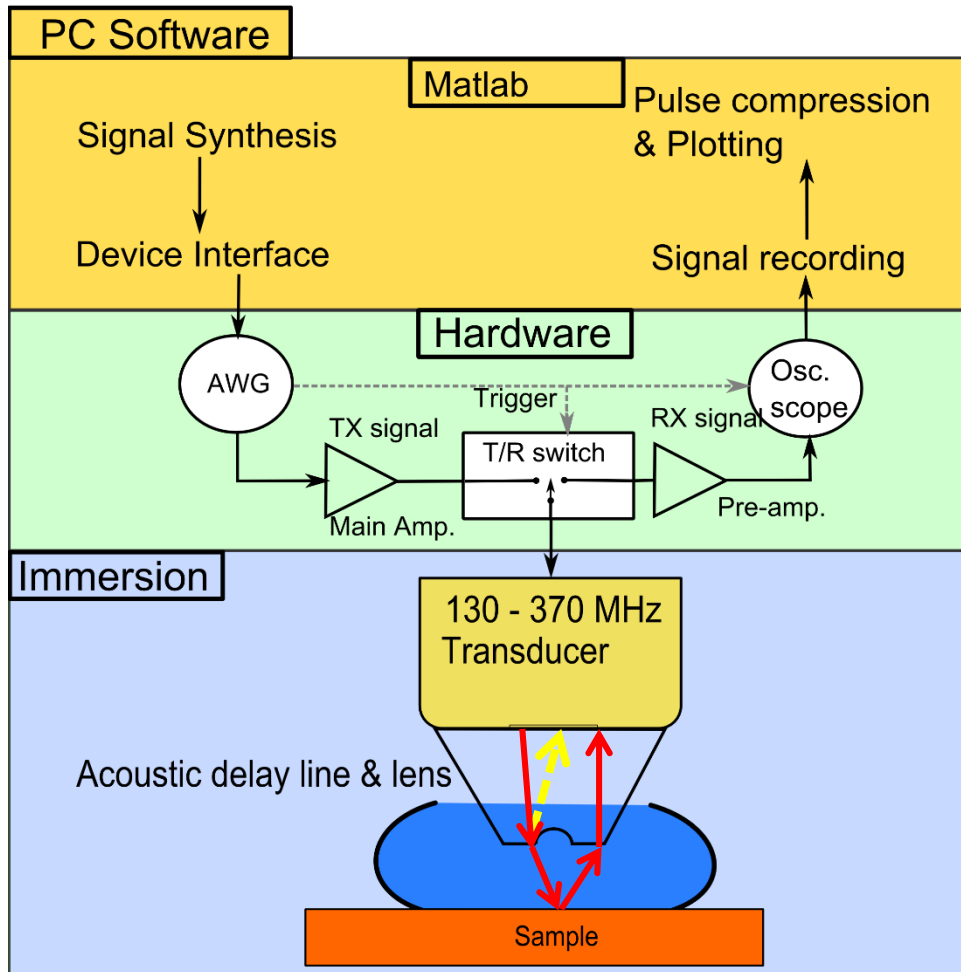
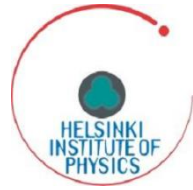
Sample

Goniometer tilt stage

XY Stage



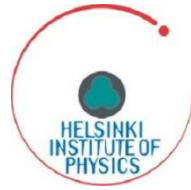
Pulse Echo Measurements



Time-of-Flight: Surface Topography
Amplitude: Mechanics



Math of Acoustic Reflection



Time-of-Flight

$$s = \frac{c_{Water}}{t}$$

C is Speed of Sound
t is Time of Flight

Echo Amplitude

$$R_{Water \rightarrow Cu} = \frac{Z_{Cu} - Z_{Water}}{Z_{Cu} + Z_{Water}} \approx 93.1 \%$$

$$R_{ref} = \frac{Z_{ref} - Z_{water}}{Z_{ref} + Z_{water}}$$

$$\frac{A_{Cu}}{A_{Ref}} = \frac{R_{Cu} (Z_{Cu})}{R_{Ref}}$$

$$Z_{Cu} = \frac{R_{ref} + \frac{A_{Ref}}{A_{Cu}}}{R_{ref} - \frac{A_{Ref}}{A_{Cu}}} Z_{Water}$$

$$Z_{Cu} = \frac{K_{Cu} + \frac{4}{3} G_{Cu}}{C_{Cu}}$$

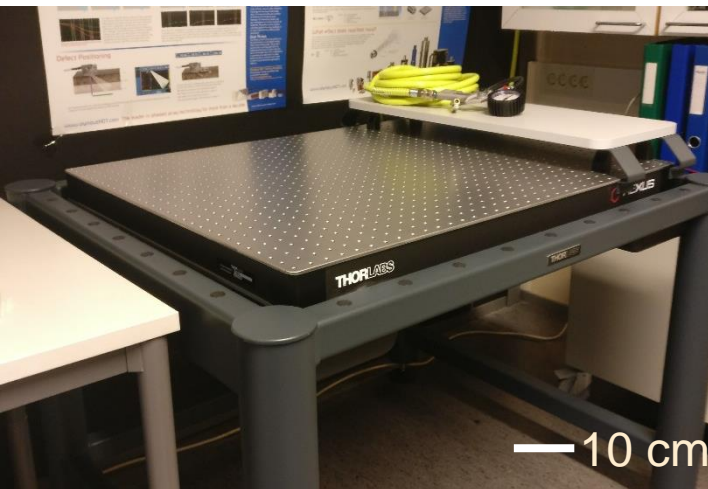
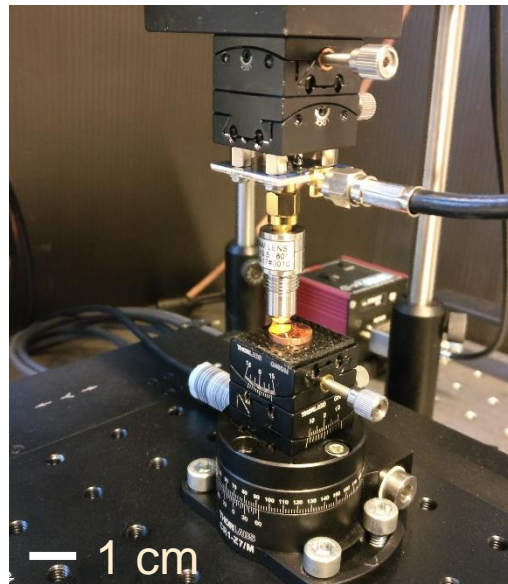
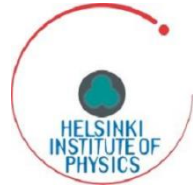
A = Echoes' Amplitude

K is Bulk Modulus

G is Shear Modulus



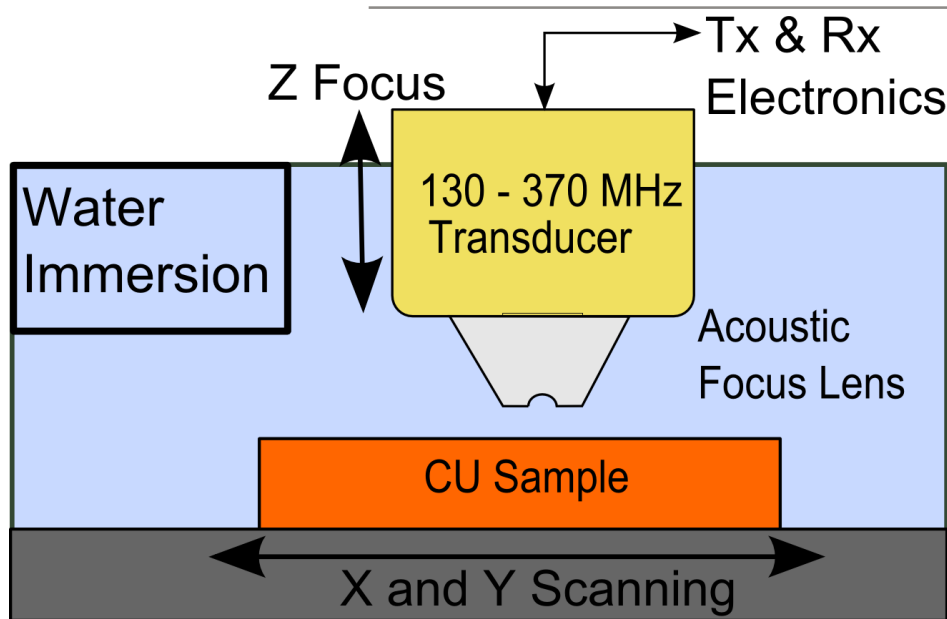
Acoustic Microscope Upgrades (Rebuild the setup)



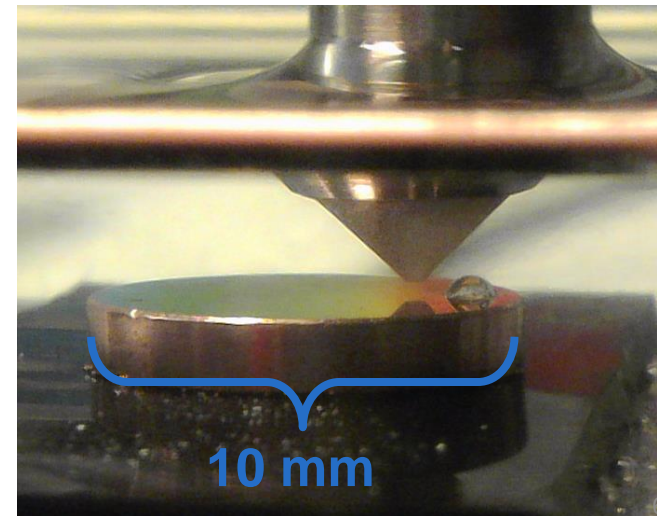
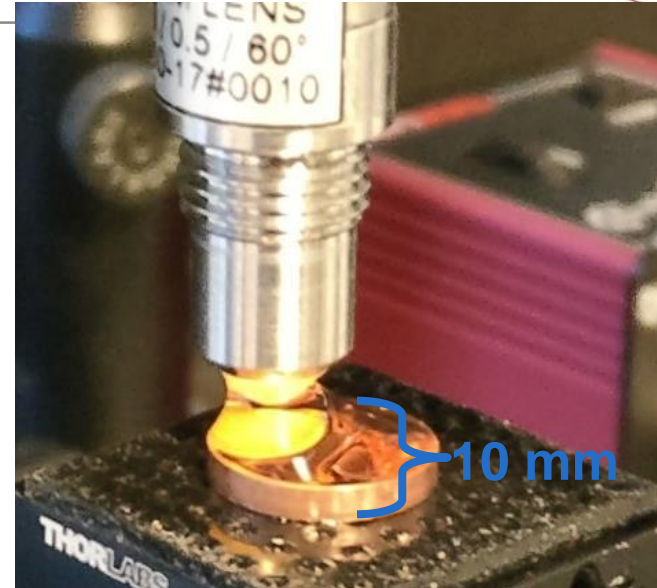
- Fast imaging of large area
- Time of 1 mm² is 1 minute (It was 1 hour)
- New components:
 - XY & Z-Stages
 - PCIe Oscilloscope
 - Custom build trigger electronics
 - Software
- Stable mechanics (Less artefacts)
 - Proper Alignment
 - Steady and smooth movement
 - Robust



Scanning Acoustic Microscopy

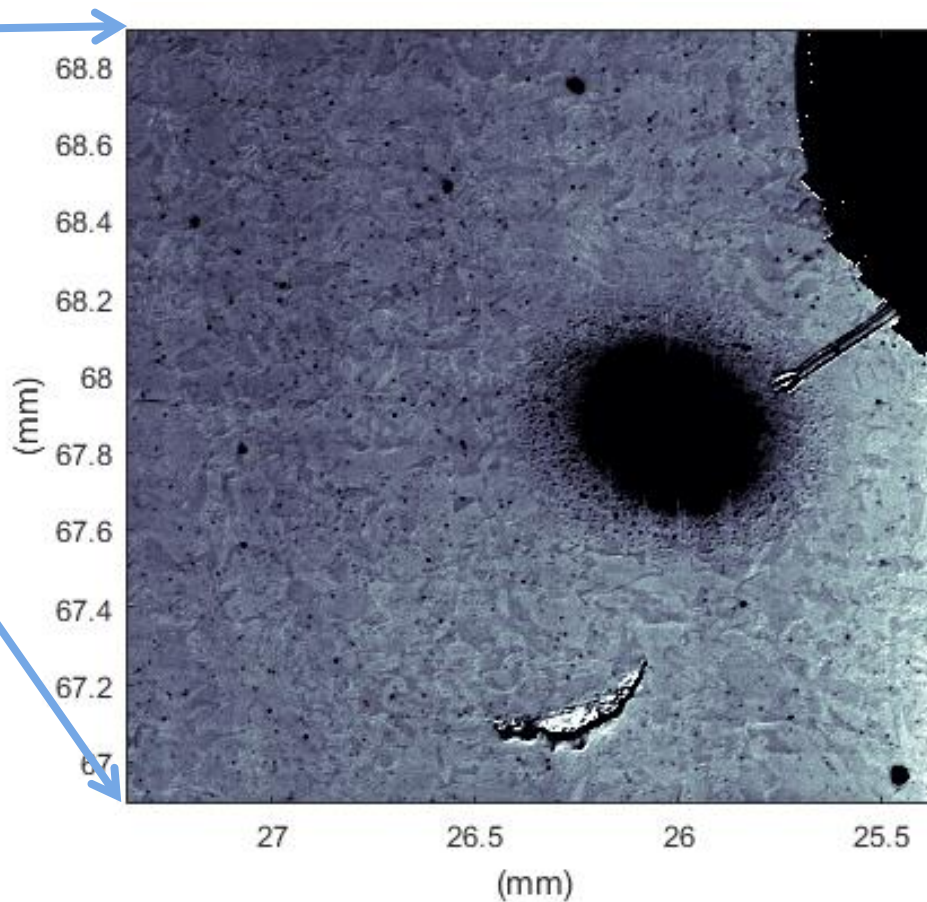
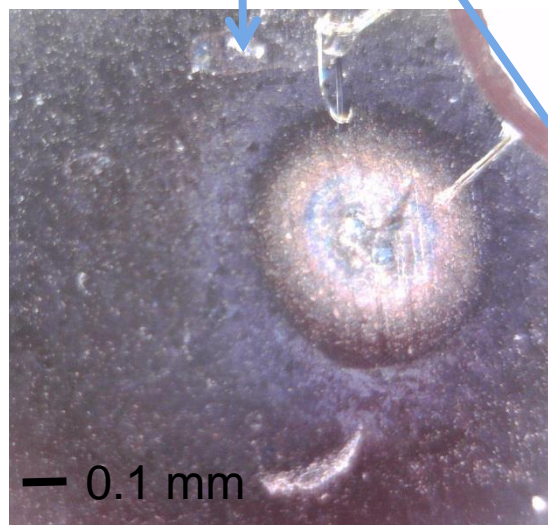
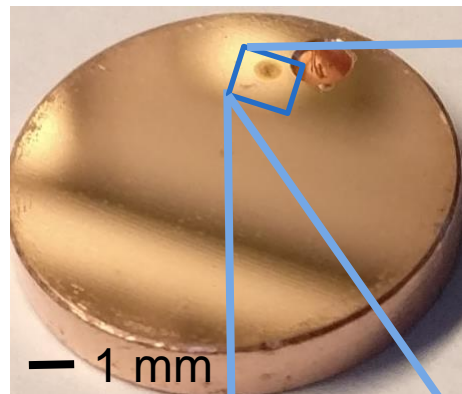


- Frequency range: 130 – 370 MHz
- Pixel-by-Pixel Imaging
- Areas 1 mm * 1 mm
 - Stepping 3 μ m
- Focus size: less than 3.5 μ m
- Imaging time: ~ 1 min/mm²

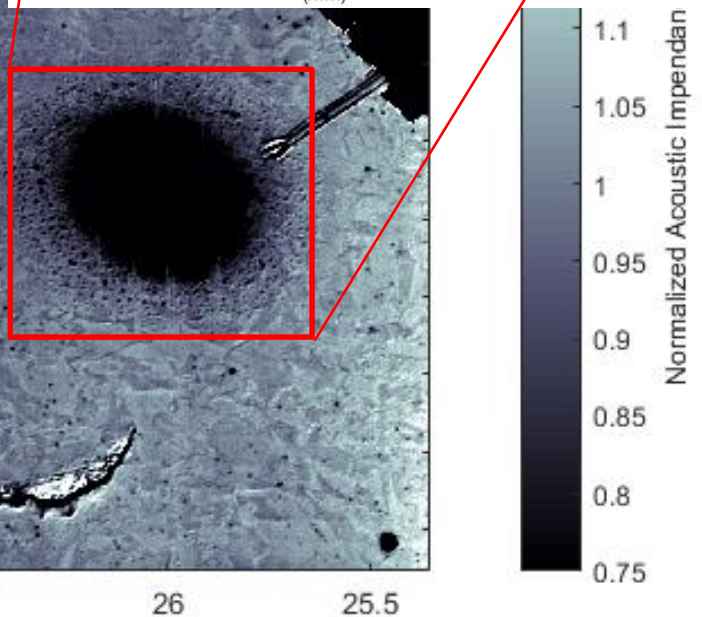
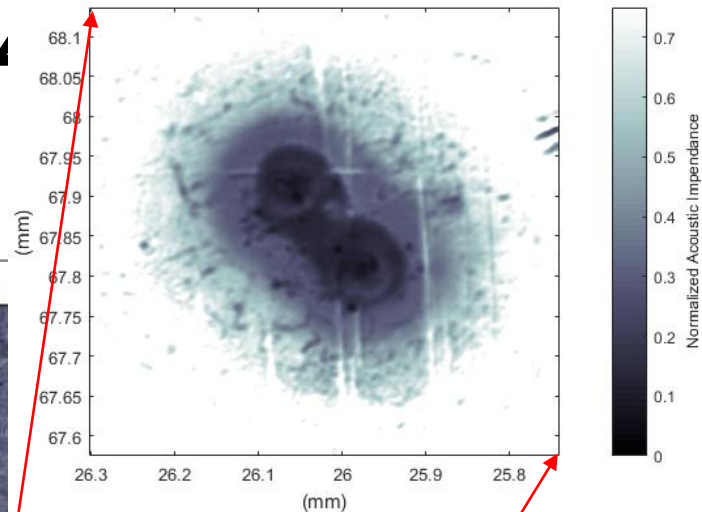
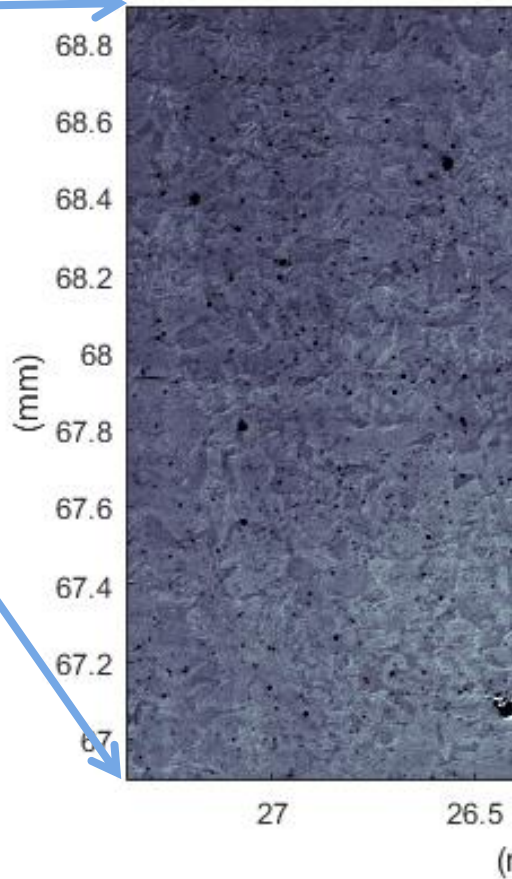
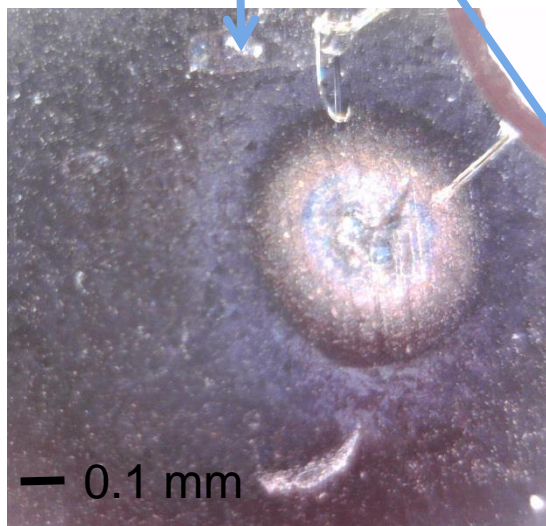
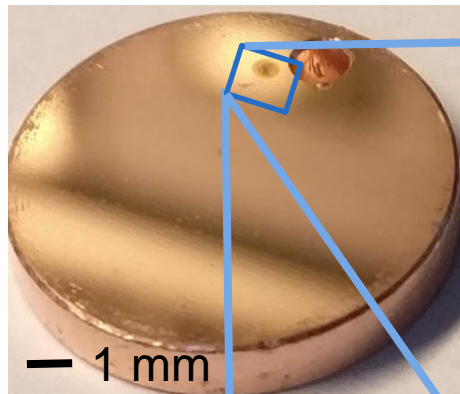


Copper Sample ID5 #495

Spark Spot

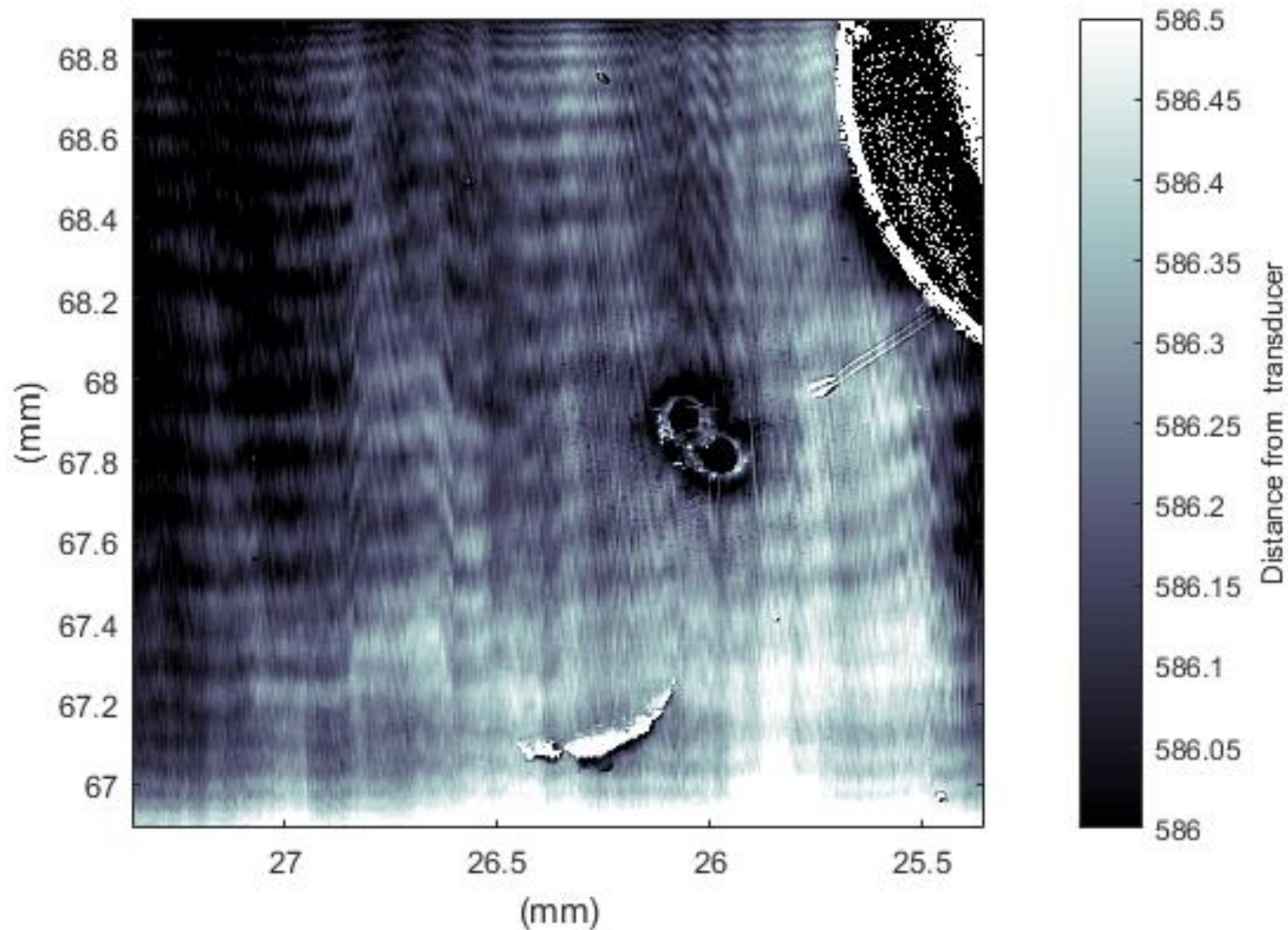
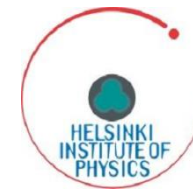


Copper Sample ID5 #1 Spark Spot





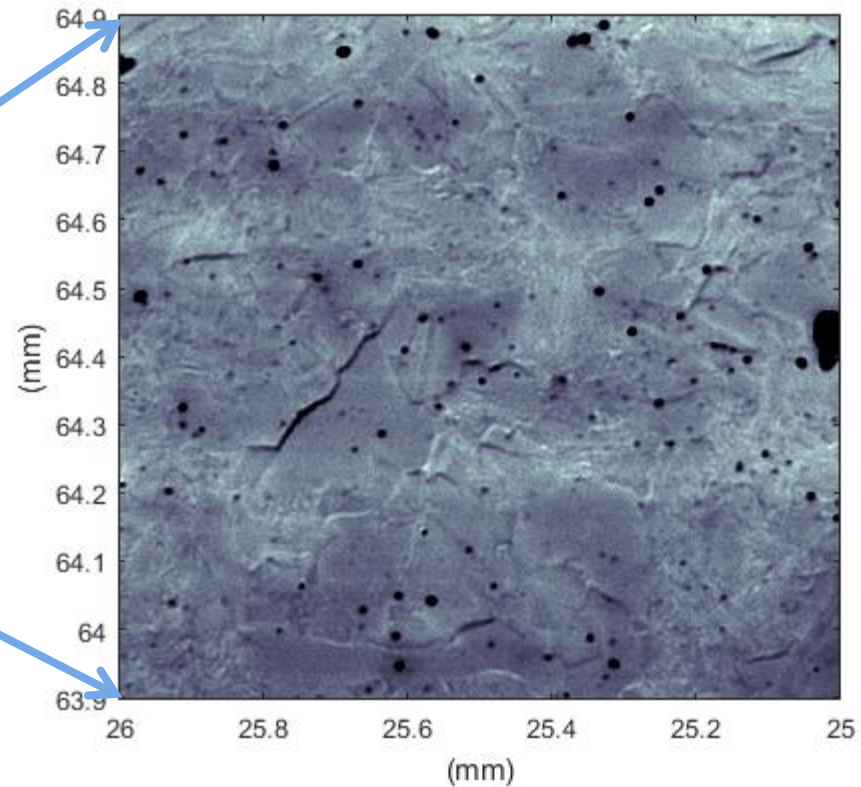
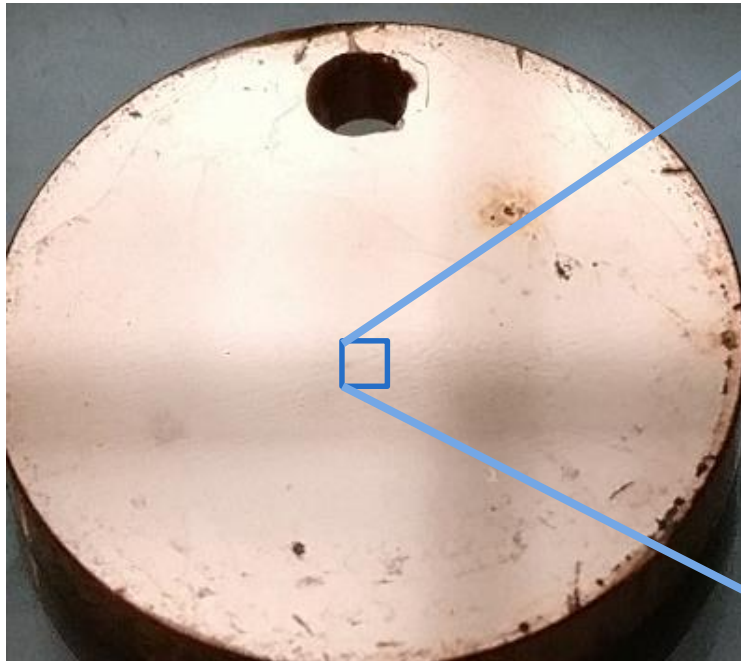
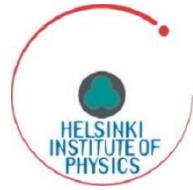
Topology of Copper Sample





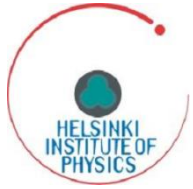
Copper Sample ID5 #23

Dark Current Field

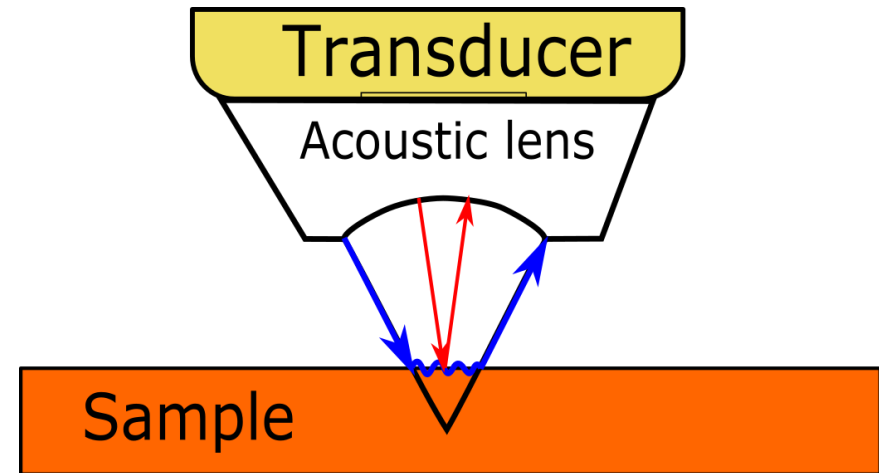




Future Work

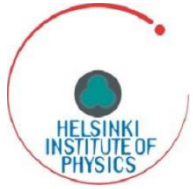


- Surface elasticity (GPa)
 - Scattering from non-flat surface
- Surface wave-velocity
 - Another acoustic parameter
 - $V(z)$ -technique
 - **Young's modulus**
- Look under the surface
 - Hard with focused transducer
 - Synthetic aperture focusing technique

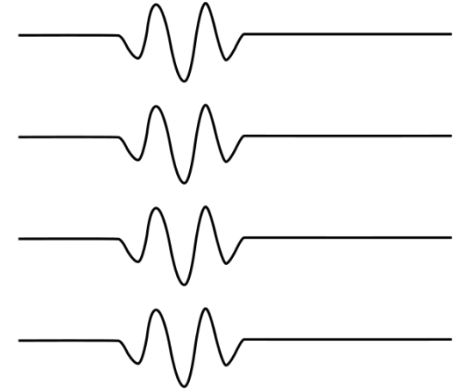
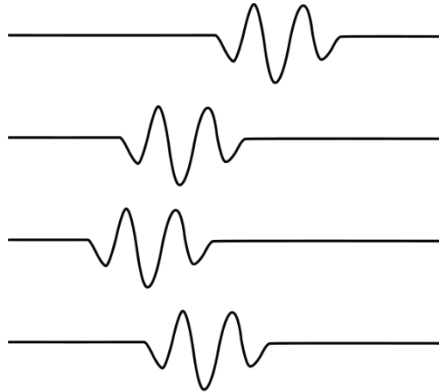




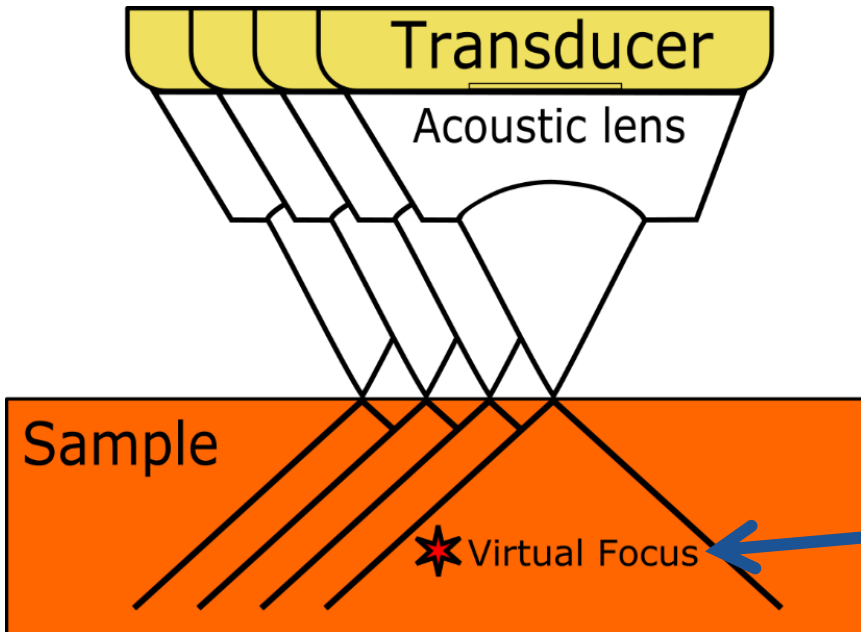
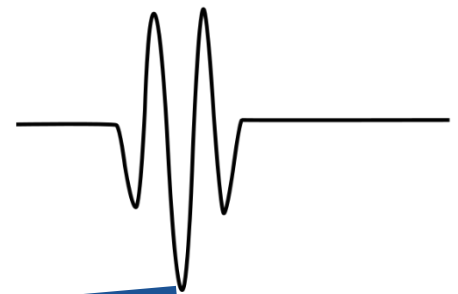
Synthetic Aperture Focusing Technique



Rx Signals



$$\Sigma(\dots) =$$





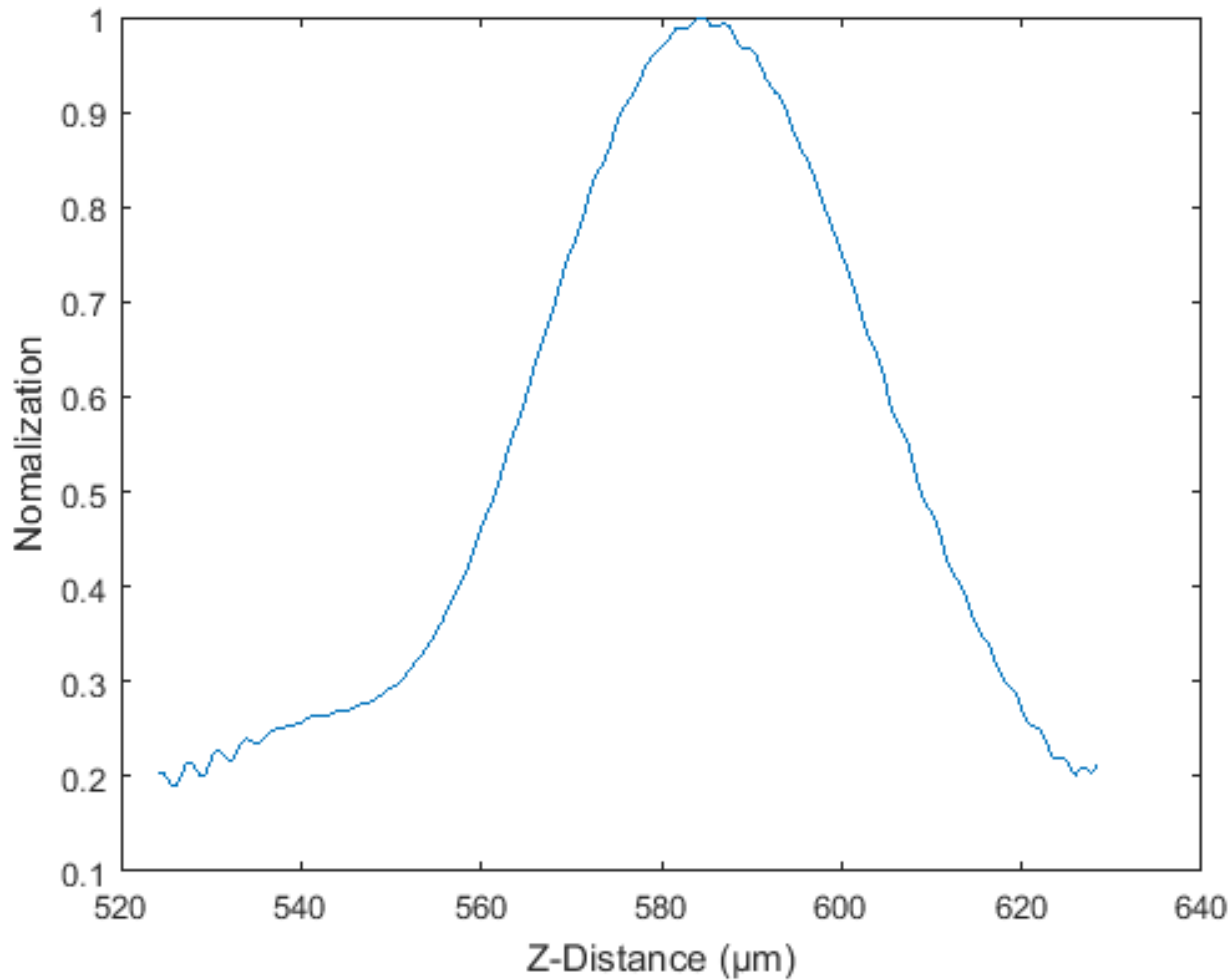
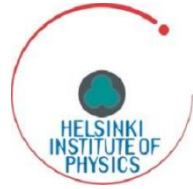
Questions and Comments



Thank You!

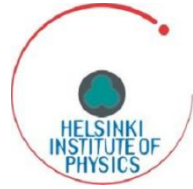


Z-Focus vs Amplitude

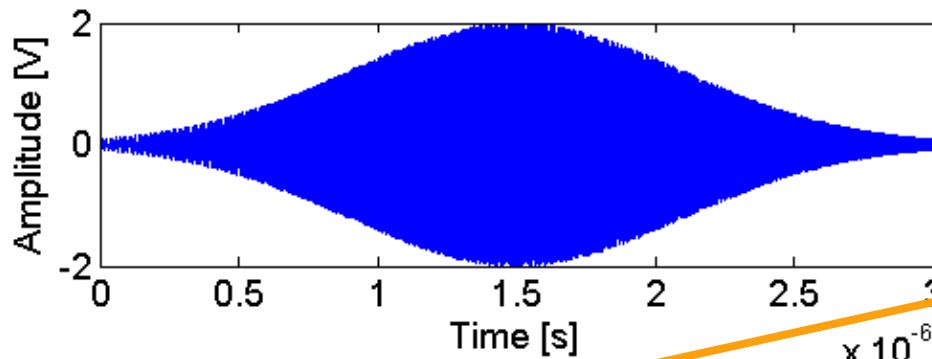




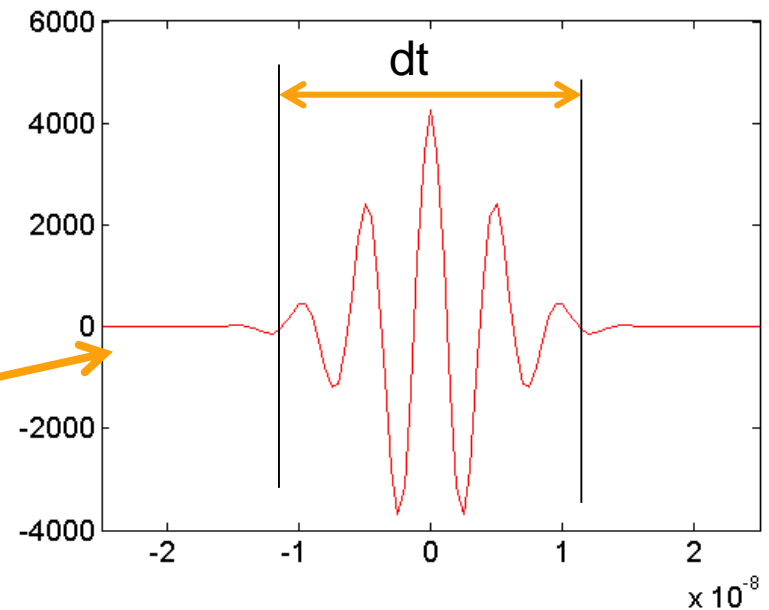
Pulse Compression Cross Correlation



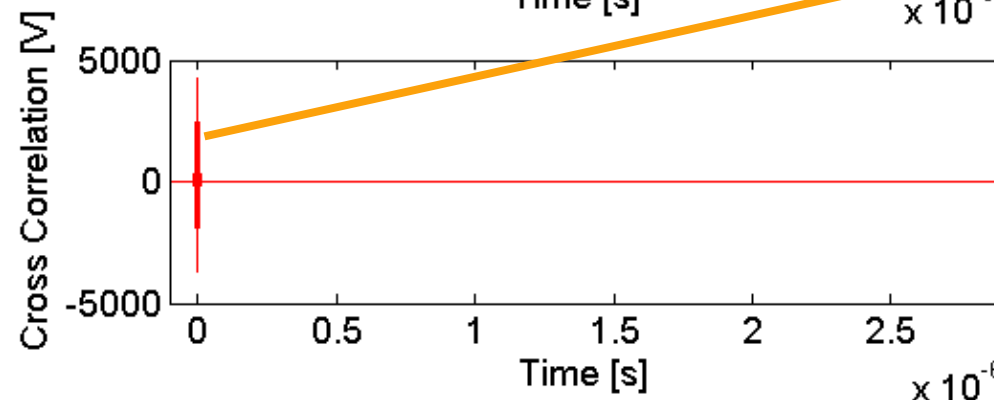
$$(f \star g)(t) \stackrel{\text{def}}{=} \int_{-\infty}^{\infty} f^*(\tau) g(t + \tau) d\tau$$



dt describes depth resolution
 dt depends on bandwidth



$$dt = \frac{1}{\Delta f} \quad dz = \frac{c}{2\Delta f}$$





Coded Signal and SNR

